

Dear customer

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Therefore, all references to "LAPIS Technology Co., Ltd.", "LAPIS Technology" and/or "LAPIS" in this document shall be replaced with "ROHM Co., Ltd." Furthermore, there are no changes to the documents relating to our products other than the company name, the company trademark, logo, etc.

Thank you for your understanding.

ROHM Co., Ltd. April 1, 2024 ROHM GROUP LAPIS TECHNOLOGY ML5810A

January 9, 2024

: Reference voltage(CFS, DFS)+10V (min)

: Reference voltage (PCFS)-9V (min)

High-Side Switch Driver IC for Battery Pack

■General Description

ML5810A is charge/discharge high-side switch Nch power MOSFET gate driver for battery pack. ML5810A assert external input reference voltage(CFS, DFS)+12V(typ) as the voltage for drive by charge pump. And also, built-in PchMOSFET gate driver for low current precharge in battery over-discharge state.

Features

- •High-side switch Nch power MOSFET gate driver for battery pack protection
- •Built-in Pch MOSFET gate driver for low current precharge/predischarge
- •80V breakdown voltage applicable to 48V battery system
- •Built-in charge pump
- •Gate driver for charge/discharge "H" output voltage
- •Gate driver for precharge/predischarge "L" output voltage
- Current consumption

• Power supply voltage range

: 210uA(typ), 480uA(max) : +6.5V to +64V

(Absolute Maximum Rating: 80V)

- Operating temperature range $:-40^{\circ}C$ to $+105^{\circ}C$
- Package : 20pin TSSOP

Application

- •E-Bike
- •Uninterruptible Power Supplies (UPS)
- Energy Storage Systems (ESS)
- •12V to 48V Battery pack for industrial

Part number

ML5810ATD.





■ Pin Configuration(Top View)



	Pin	I/O	Description
	ГШ	1/0	
1	VDD	_	Power supply. Connect an external CR filter for noise rejection.
2	NC	_	_
3	DFETON	Ι	D_FET enable input.(pulldown resistance:1M Ω)
4	PCFETON	I	PC_FET enable input.(pulldown resistance:1MΩ)
5	CFETON	Ι	C_FET enable input.(pulldown resistance:1MΩ)
6	TEST_N	I	TEST_N input. Should be fixed to VDD.
7	TEST1	I	TEST1 input.(pulldown resistance:1M Ω) Should be fixed to GND.
8	TEST2	Ι	TEST2 input.(pulldown resistance:1M Ω) Should be fixed to GND.
9	GND		Ground.
10	VREG	0	Built-in 3.3V regurator output. Connect a $4.7\mu F$ capacitor between this pin and GND.
11	DFS	Ι	Reference voltage input for the D_FET drive charge pump. Connect to the source pin of the discharge FET.
12	D_FET	0	Discharge Nch-FET gate drive. Connect to the gate pin of the external Nch-FET. In the ON state, the DFS level +12V (typ) is asserted.In the OFF state DFS level is asserted.
13	CPHD	0	Charge pump capacitor input for D_FET drive. Connect a capacitor which
14	CPLD	0	approximately 8-times of the discharge FET gate capacitance, between the CPHD and CPLD pins.
15	PC_FET	0	Precharge/predischarge Pch-FET gate drive. Connected to the gate pin of the external Pch-FET. In the ON state, the PCFS level -12V (typ) is asserted, while the PCFS level is asserted in the OFF state.
16	PCFS	Ι	Reference voltage input for the PC_FET drive charge pump. Connected to the source pin of the precharge/predischarge FET.
17	CPLC	0	Charge pump capacitor input for C_FET drive. Connect a capacitor with
18	CPHC	0	approximately twice the gate capacitance of the charge FET between the CPHC and CPLC pins.
19	C_FET	0	Charge Nch-FET gate drive. Connected to the gate pin of the external Nch-FET. In the ON state, the CFS level +12V (typ) is asserted, while the CFS level is asserted in the OFF state.
20	CFS	I	Reference voltage input for the C_FET drive charge pump. Connected to the source pin of the charge FET.

		5	G	SND=0V, Ta=25°C
Parameter	Symbol	Condition	Rating	Unit
Supply voltage	V _{DD}	Applied to VDD pin	-0.3 to +86.5	V
	V _{IN1}	Applied to CFS,DFS, and PCFS pins	-0.3 to +86.5	V
Input voltage	Vin2	Applied to CFETON, DFETON,PCFETON,TEST1, and TEST2,TEST_N pins	-0.3 to VDD+0.3	V
	V _{OUT1}	Applied to D_FET pin V _{DFS} =DFS pin voltage	V _{DFS} -0.5 to +86.5	V
Output voltage	V _{OUT2}	Applied to C_FET pin V _{CFS} =CFS pin voltage	V _{CFS} -0.5 to +86.5	V
	Vout3	Applied to PC_FET pin	-0.5 to +71.5	V
	I _{OS1}	VDD=50V Applied to VREG pin	5	mA
Short circuit output current	I _{OS2}	VDD=50V Applied to C_FET and D_FET pins	20	mA
	los3	VDD=50V Applied to PC_FET pin	2	mA
Power dissipation	PD	Ta=25°C	2.3	W
Package thermal resistance	θja	JEDEC double-side board mounted	33.7	°C/W
Storage temperature	T _{STG}	—	-55 to +150	°C

■Absolute Maximum Ratings

■Recommended Operating Conditions

·	C			(GND= 0 V)
Parameter	Symbol	Condition	Range	Unit
Power supply voltage	V _{DD}	Applied to VDD pin	6.5~64	V
Operating temperature	Та	No VREG output load	$-40 \sim +105$	°C

■ Electrical Characteristics

V _{DD} =6.5~64V,GND=0V,Ta=-40 to +105°C, no VREG output load						load
Parameter Symbol		Condition	Min.	Тур.	Max.	Unit
Digital "H" input voltage(*1)	Vih	—	2.15	_	VDD+0.3	V
Digital "L" input voltage(*1)	VIL	—	0	_	0.35	V
Digital "H" input current(*1)	Іін	$V_{IH} = VDD$	—		130	μA
Digital "L" input current(*1)	ΙıL	VIL = GND	-2		—	μA
C_FET / D_FET output	Voh11	I _{OH} =-1.5µА (V _{DD} *0.95)≧10V	10	12	15	V
D_FET-DFS)	Voh12	I _{OH} =-1.5µА (V _{DD} *0.93) <10V	V _{DD} *0.93		V _{DD}	V
PC_FET output voltage	V _{OL21}	I _{OL} =+1.5μΑ (V _{DD} *0.8)≧9V	9	12	15	V
(PCFS-PC_FET)	Vol22	I _{OL} =+1.5µA (V _{DD} *0.8)≪9V	V _{DD} *0.8	_	V _{DD}	V
C_FET / D_FET rise time		Ccp=80nF, Rg=1kΩ, Rfs=100Ω, FET gate capacitance=10nF From FET-on to 80% of output voltage V _{OH11} , V _{OH12}	_	150	350	us
C_FET / D_FET fall time	Tfetf1	Ccp=80nF, Rg=1kΩ, Rfs=100Ω, FET gate capacitance=10nF From FET-off to 20% of output voltage V _{OH11} , V _{OH12}	_	40	70	us
PC_FET fall time	Tfetf2	Ccp=80nF, Rg=1kΩ, Rfs=1kΩ, FET gate capacitance=1nF From FET-on to 80% of output voltage V _{0L21} , V _{0L22}	_	110	400	us
PC_FET rise time Tfetr2		Ccp=80nF, Rg=1kΩ, Rfs=1kΩ, FET gate capacitance=1nF From FET-off to 20% of output voltage VoL21, VoL22	_	20	70	us
Current consumption in operation (charge and discharge) (*2)		CFETON=1 & DFETON=1 & PCFETON=0 VDD=CFS=DFS=PCFS	_	210	480	uA
(°2) Current consumption in operation (precharge or predischarge)(*2) IDD2 CFETON=0 & DFETON=0		_	135	380	uA	

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VREG output voltage	V _{REG1}	V _{DD} =6.5V~64V Output load current<1mA	3.0	3.3	3.6	V
C_FET / D_FET charge pump frequency	F _{CPCD}	_	6.25	7.8125	9.4	kHz
PC_FET	FCPPC	_	0.78	0.9766	1.2	kHz

*1: Applied to CFETON, DFETON, PCFETON, TEST1, TEST2 and TEST_N pins

*2: Current consumption are sum of VDD,CFS,DFS, and PCFS currents

■ Functional Description

Operating state of ML5810A in each input status of 3 control input(PCFETON, DFETON, CFETON) is indicated in the following table.

"Charge pump ON, FET stand-by" is in which a charge pump powers up and each FET gate voltage output enable. The wait time is required at transition from power-up, and please refer to the "Iming diagram" mentioned later for details.

"FET ON state" is the state in which each FET gate voltage is asserted by a relevant pin actually. Please refer to "■ electrical characteristic" about rise and fall time of gate voltage.

	Input		ML5810A
PCFETON	FETON DEFTON CETON		Operating status
0 0 0			Charge pump ON, FET stand-by
Мс	ore than one is	"1"	FET ON

C_FET and D_FET can be turn on at the same time, but PC_FET is exclusively other FETs and can't be turn on at the same time. A truth table of FET ON/OFF is following. As it's shown on the table, CFETON, DFETON is priority more than PCFETON.

	Input		Output		
PCFETON	DFETON	CFETON	PC_FET	D_FET	C_FET
0	0	0	OFF	OFF	OFF
0 or 1	0	1	OFF	OFF	ON
0 or 1	1	0	OFF	ON	OFF
0 or 1	1	1	OFF	ON	ON
1	0	0	ON	OFF	OFF



(*) Twait must be more than 50ms, when CFETON, DFETON, and PCFETON are set to H from L (0v).

■ Application Circuit Example



Recommended Values for External Components

Component	Recommended value
R _{VDD} (*1)	510Ω to 1.5kΩ
	2.2μF to 10μF
	4.7μF
R _{G1}	1kΩ
R _{FS1}	100Ω
R _{G2}	1kΩ
R _{FS2}	1kΩ
R _{GS}	10MΩ
C _{CP}	82nF (*2)

(*1) Recommended R_{VDD} =1.5k Ω for C_{VDD} =2.2 μ F.

(*2) Set 80nF to 100nF, when gate capacitance of external Nch-FET is 10nF. Set about 8-times of gate capacitance of external Nch-FET to C_{CP} .

(*3) Set R_{PC} according to current of Pch-FET.

Notice: Example of application circuit and the recommended values to parts list shall not guarantee performance under all conditions. Full and detailed tests are suggested on your actual application.

Package Dimensions



Causion regarding surface mount type packages

Surface mount type packages are susceptible to applied heat in solder reflow or moisture absorption during storage. Please contact your local ROHM sales representative for the recommended mounting conditions (reflow sequence, temperature and cycles) and storage environment.

Revision History

Decument No.	lagua data	Page		Descriptions
Document No.	issue date	Previous	New	Descriptions
Version-02	2019.07.18			English version first edition issued
Version-03	2019.07.19	3	3	Error in writing corrected
Version-03	2019.07.25	5,10	5,10	Error in writing corrected
Version-04	2020.06.05	3	3	Error in Pin Configuration corrected (pin 2,8,15,16)
Version-04	2020.06.05	10	10	■Application Circuit Example Added TEST1, TEST2, TEST_N pin.
Version-05	2020.10.30	_	_	Changed Company name and "notes" page.
Version-06	2023.06.09	11	11	Changed "Package Dimensions".
Version-07	Jan. 9, 2024	1	1	Add Application Part number
		13	13	Add Notes

<u>Notes</u>

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